

Search Notes

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Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

SIEGEL ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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264	316,338	4/26/2009	EHL
264	272.17	4/26/2009	EHL
264	272.14	4/26/2009	EHL
264/272.15,328.4,328.5		4/26/2009	EHL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated	4/26/2009	EHL
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